

Voltage Detector IC Series

# Low Voltage Free Delay Time Setting CMOS Voltage Detector IC Series

**BU42xx series BU43xx series**

● **General Description**

ROHM's BU42xx and BU43xx series are CMOS Voltage Detector ICs with adjustable output delay. It is a high-accuracy, low current consumption Voltage Detector IC series with a built-in delay circuit. The lineup was established with two output types (Nch open drain and CMOS output) and detection voltages range from 0.9V to 4.8V in increments of 0.1V, so that the series may be selected according to application.

● **Features**

- Delay Time Controlled by external Capacitor
- Two output types (Nch open drain and CMOS output)
- Ultra-low current consumption
- Wide operating temperature range
- Very small and low height package
- Package SSOP5 and SOP4 is similar to SOT-23-5 and SC-82 respectively (JEDEC)

● **Key Specifications**

- Detection voltage: 0.9V to 4.8V (Typ.)  
0.1V steps
- High accuracy detection voltage: ±1.0%
- Ultra-low current consumption: 0.55µA (Typ.)
- Operating temperature range: -40°C to +125°C

● **Package**

- SSOP5:  2.90mm x 2.80mm x 1.25mm
- SOP4:  2.00mm x 2.10mm x 0.95mm
- VSO5:  1.60mm x 1.60mm x 0.60mm

● **Applications**

Circuits using microcontrollers or logic circuits that require a reset.

● **Typical Application Circuit**



● **Connection Diagram & Pin Descriptions**

**SSOP5**

TOP VIEW



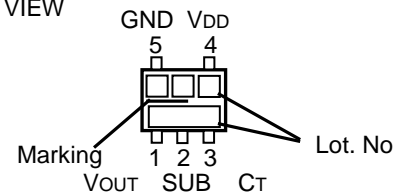
**SOP4**

TOP VIEW



**VSO5**

TOP VIEW



PIN No.	Symbol	Function
1	VOUT	Reset output
2	VDD	Power supply voltage
3	GND	GND
4	N.C.	Unconnected terminal
5	CT	Capacitor connection terminal for output delay time

PIN No.	Symbol	Function
1	GND	GND
2	VDD	Power supply voltage
3	CT	Capacitor connection terminal for output delay time
4	VOUT	Reset output

PIN No.	Symbol	Function
1	VOUT	Reset output
2	SUB	Substrate*
3	CT	Capacitor connection terminal for output delay time
4	VDD	Power supply voltage
5	GND	GND

\*Connect the substrate to VDD

●Ordering Information

B	U	X	X	X	X	X	-	T	R
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Part Number	Output Type 42 : Open Drain 43 : CMOS	Reset Voltage Value 09 : 0.9V ↓ 0.1V step 48 : 4.8V	Package G : SSOP5 F : SOP4 FVE : VSOF5	Packaging and forming specification TR : Embossed tape and reel
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SSOP5



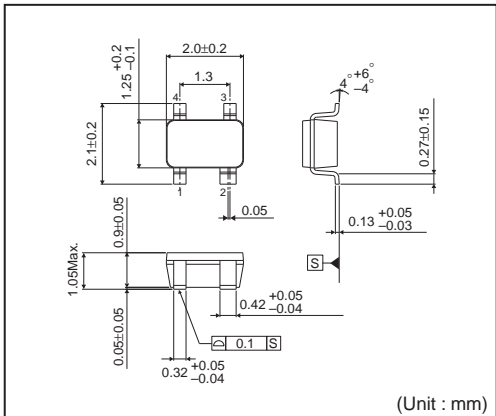
<Tape and Reel information>

Tape	Embossed carrier tape
Quantity	3000pcs
Direction of feed	TR (The direction is the 1pin of product is at the upper right when you hold reel on the left hand and you pull out the tape on the right hand)

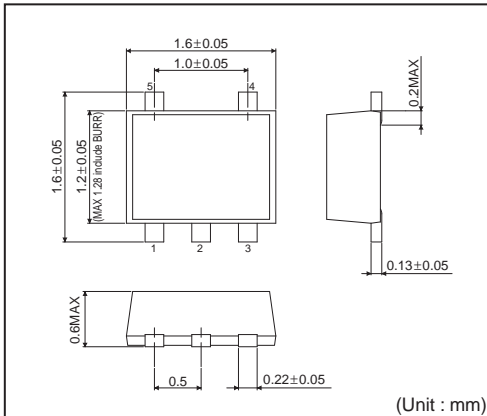


\*Order quantity needs to be multiple of the minimum quantity.

SOP4



VSOF5



## ●Lineup

Output Type	Open Drain		CMOS	
Detection Voltage	Marking	Part Number	Marking	Part Number
4.8V	ZR	BU4248	1H	BU4348
4.7V	ZQ	BU4247	1G	BU4347
4.6V	ZP	BU4246	1F	BU4346
4.5V	ZN	BU4245	1E	BU4345
4.4V	ZM	BU4244	1D	BU4344
4.3V	ZL	BU4243	1C	BU4343
4.2V	ZK	BU4242	1B	BU4342
4.1V	ZJ	BU4241	1A	BU4341
4.0V	ZH	BU4240	0Z	BU4340
3.9V	ZG	BU4239	0Y	BU4339
3.8V	ZF	BU4238	0X	BU4338
3.7V	ZE	BU4237	0W	BU4337
3.6V	ZD	BU4236	0V	BU4336
3.5V	ZC	BU4235	0U	BU4335
3.4V	ZB	BU4234	0T	BU4334
3.3V	ZA	BU4233	0S	BU4333
3.2V	YZ	BU4232	0R	BU4332
3.1V	YY	BU4231	0Q	BU4331
3.0V	YX	BU4230	0P	BU4330
2.9V	YW	BU4229	0N	BU4329
2.8V	YV	BU4228	0M	BU4328
2.7V	YU	BU4227	0L	BU4327
2.6V	YT	BU4226	0K	BU4326
2.5V	YS	BU4225	0J	BU4325
2.4V	YR	BU4224	0H	BU4324
2.3V	YQ	BU4223	0G	BU4323
2.2V	YP	BU4222	0F	BU4322
2.1V	YN	BU4221	0E	BU4321
2.0V	YM	BU4220	0D	BU4320
1.9V	YL	BU4219	0C	BU4319
1.8V	YK	BU4218	0B	BU4318
1.7V	YJ	BU4217	0A	BU4317
1.6V	YH	BU4216	ZZ	BU4316
1.5V	YG	BU4215	ZY	BU4315
1.4V	YF	BU4214	ZX	BU4314
1.3V	YE	BU4213	ZW	BU4313
1.2V	YD	BU4212	ZV	BU4312
1.1V	YC	BU4211	ZU	BU4311
1.0V	YB	BU4210	ZT	BU4310
0.9V	YA	BU4209	ZS	BU4309

## ● Absolute Maximum Ratings

Parameter		Symbol	Limit	Unit
Power Supply Voltage		V <sub>DD</sub>	-0.3 to +7	V
Output Voltage	Nch Open Drain Output	V <sub>OUT</sub>	GND-0.3 to +7	V
	CMOS Output		GND-0.3 to V <sub>DD</sub> +0.3	
Output Current		I <sub>o</sub>	70	mA
Power Dissipation	SSOP5(SOT-23-5) <sup>*1*4</sup>	P <sub>d</sub>	540	mW
	SOP4(SC-82) <sup>*2*4</sup>		400	
	VSO5 <sup>*3*4</sup>		210	
Operation Temperature Range		T <sub>opt</sub>	-40 to +125	°C
Ambient Storage Temperature		T <sub>stg</sub>	-55 to +125	°C

\*1 Reduced by 5.4mW/°C when used over 25°C.

\*2 Reduced by 4.0mW/°C when used over 25°C.

\*3 Reduced by 2.1mW/°C when used over 25°C.

\*4 When mounted on ROHM standard circuit board (70mm×70mm×1.6mm, glass epoxy board).

## ● Electrical Characteristics (Unless Otherwise Specified Ta=-25 to 125°C)

Parameter	Symbol	Condition	Limit			Unit		
			Min.	Typ.	Max.			
Detection Voltage	V <sub>DET</sub>	V <sub>DD</sub> =H→L, Ta=25°C, R <sub>L</sub> =470kΩ	V <sub>DET</sub> (T) ×0.99	V <sub>DET</sub> (T)	V <sub>DET</sub> (T) ×1.01	V		
			V <sub>DET</sub> =1.8V	Ta=+25°C	1.782		1.8	1.818
				Ta=-40°C to 85°C	1.741		-	1.860
		Ta=85°C to 125°C		1.718	-		1.883	
		V <sub>DET</sub> =2.5V	Ta=+25°C	2.475	2.5		2.525	
			Ta=-40°C to 85°C	2.418	-		2.584	
			Ta=85°C to 125°C	2.386	-		2.615	
		V <sub>DET</sub> =3.0V	Ta=+25°C	2.970	3.0		3.030	
			Ta=-40°C to 85°C	2.901	-		3.100	
			Ta=85°C to 125°C	2.864	-		3.139	
		V <sub>DET</sub> =3.3V	Ta=+25°C	3.267	3.3		3.333	
			Ta=-40°C to 85°C	3.191	-		3.410	
Ta=85°C to 125°C	3.150		-	3.452				
V <sub>DET</sub> =4.2V	Ta=+25°C	4.158	4.2	4.242				
	Ta=-40°C to 85°C	4.061	-	4.341				
	Ta=85°C to 125°C	4.009	-	4.394				
Circuit Current when ON	I <sub>DD1</sub>	V <sub>DD</sub> =V <sub>DET</sub> -0.2V	V <sub>DET</sub> = 0.9 to 1.3V	-	0.15	μA		
			V <sub>DET</sub> = 1.4 to 2.1V	-	0.20			
			V <sub>DET</sub> = 2.2 to 2.7V	-	0.25			
			V <sub>DET</sub> = 2.8 to 3.3V	-	0.30			
			V <sub>DET</sub> = 3.4 to 4.2V	-	0.35			
			V <sub>DET</sub> = 4.3 to 4.8V	-	0.40			
Circuit Current when OFF	I <sub>DD2</sub>	V <sub>DD</sub> =V <sub>DET</sub> +2.0V	V <sub>DET</sub> = 0.9 to 1.3V	-	0.30	μA		
			V <sub>DET</sub> = 1.4 to 2.1V	-	0.35			
			V <sub>DET</sub> = 2.2 to 2.7V	-	0.40			
			V <sub>DET</sub> = 2.8 to 3.3V	-	0.45			
			V <sub>DET</sub> = 3.4 to 4.2V	-	0.50			
			V <sub>DET</sub> = 4.3 to 4.8V	-	0.55			
Operating Voltage Range	V <sub>OPL</sub>	V <sub>OL</sub> ≤ 0.4V, Ta=25 to 125°C, R <sub>L</sub> =470kΩ	0.70	-	-	V		
		V <sub>OL</sub> ≤ 0.4V, Ta=-40 to 25°C, R <sub>L</sub> =470kΩ	0.90	-	-			
'High' Output Voltage (Pch)	V <sub>OH</sub>	V <sub>DD</sub> =4.8V, I <sub>SOURCE</sub> =1.7 mA, V <sub>DET</sub> =0.9V to 3.9V	V <sub>DD</sub> -0.5	-	-	V		
		V <sub>DD</sub> =6.0V, I <sub>SOURCE</sub> =2.0 mA, V <sub>DET</sub> =4.0V to 4.8V	V <sub>DD</sub> -0.5	-	-	V		
'Low' Output Voltage (Nch)	V <sub>OL</sub>	V <sub>DD</sub> =0.85V, I <sub>SINK</sub> = 20 μA	-	-	0.05	V		
		V <sub>DD</sub> =1.5V, I <sub>SINK</sub> = 1 mA, V <sub>DET</sub> =1.7 to 4.8V	-	-	0.5	V		
		V <sub>DD</sub> =2.4V, I <sub>SINK</sub> = 3.6 mA, V <sub>DET</sub> =2.7 to 4.8V	-	-	0.5			

\*1: Design Guarantee. (Outgoing inspection is not done on all products.)

V<sub>DET</sub>(T): Standard Detection Voltage (0.9V to 4.8V, 0.1V step)R<sub>L</sub>: Pull-up resistor to be connected between V<sub>OUT</sub> and power supply.

## ●Electrical Characteristics (Unless Otherwise Specified Ta=-25 to 125°C) - continued

Parameter	Symbol	Condition	Limit			Unit	
			Min.	Typ.	Max.		
Leak Current when OFF	I <sub>leak</sub>	V <sub>DD</sub> =V <sub>D</sub> S=7V Ta=-40 to 85°C	-	0	0.1	μA	
		V <sub>DD</sub> =V <sub>D</sub> S=7V Ta=85 to 125°C	-	0	1		
CT pin Threshold Voltage	V <sub>CTH</sub>	V <sub>DD</sub> =V <sub>DET</sub> ×1.1, V <sub>DET</sub> =0.9 to 2.5V Ta=25°C R <sub>L</sub> =470kΩ	V <sub>DD</sub> ×0.35	V <sub>DD</sub> ×0.45	V <sub>DD</sub> ×0.55	V	
		V <sub>DD</sub> =V <sub>DET</sub> ×1.1, V <sub>DET</sub> =2.6 to 4.8V Ta=25°C R <sub>L</sub> =470kΩ	V <sub>DD</sub> ×0.40	V <sub>DD</sub> ×0.50	V <sub>DD</sub> ×0.60		
Output Delay Resistance	R <sub>CT</sub>	V <sub>DD</sub> =V <sub>DET</sub> ×1.1 V <sub>CT</sub> =0.5V Ta=25°C *1	9	10	11	MΩ	
CT pin Output Current	I <sub>CT</sub>	V <sub>CT</sub> =0.1V V <sub>DD</sub> =0.85V	5	40	-	μA	
		V <sub>CT</sub> =0.5V V <sub>DD</sub> =1.5V V <sub>DET</sub> =1.7 to 4.8V	200	400	-		
Detection Voltage Temperature coefficient	V <sub>DET</sub> /ΔT	Ta=-40°C to 125°C	-	±30	-	ppm/°C	
Hysteresis Voltage	ΔV <sub>DET</sub>	V <sub>DD</sub> =L→H→L Ta=-40 to 125°C R <sub>L</sub> =470kΩ	V <sub>DET</sub> ≤1.0V	V <sub>DET</sub> ×0.03	V <sub>DET</sub> ×0.05	V <sub>DET</sub> ×0.08	V
			V <sub>DET</sub> ≥1.1V	V <sub>DET</sub> ×0.03	V <sub>DET</sub> ×0.05	V <sub>DET</sub> ×0.07	

\*1: Design Guarantee. (Outgoing inspection is not done on all products.)

V<sub>DET</sub>(T): Standard Detection Voltage (0.9V to 4.8V, 0.1V step)

R<sub>L</sub>: Pull-up resistor to be connected between V<sub>OUT</sub> and power supply.

●Block Diagrams



Fig.1 BU42xx Series

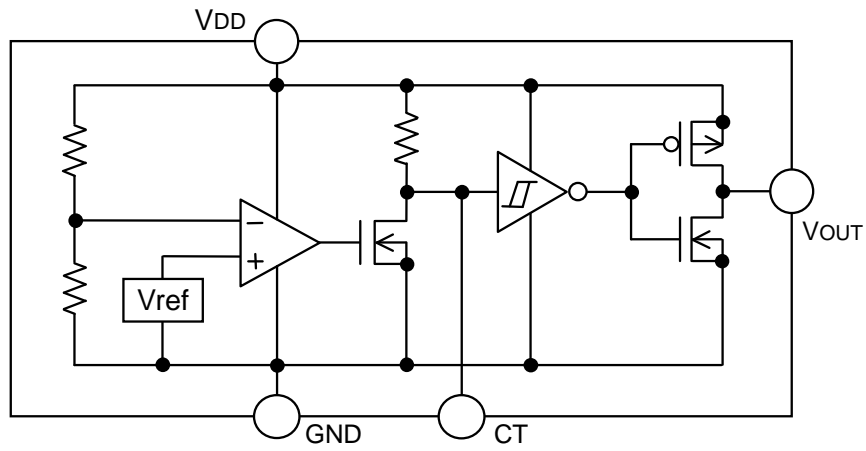


Fig.2 BU43xx Series

● Typical Performance Curves



Fig.3 Circuit Current



Fig.4 "LOW" Output Current



Fig.5 "High" Output Current



Fig.6 I/O Characteristics

● Typical Performance Curves – continued



Fig.7 Operating Limit Voltage



Fig.8 CT Terminal Current



Fig.9 Detecting Voltage Release Voltage



Fig.10 Circuit Current when ON

● Typical Performance Curves – continued



Fig.11 Circuit Current when OFF



Fig.12 Operating Limit Voltage



Fig.13  $C_T$  Terminal Circuit Resistance



Fig.14 Delay Time ( $t_{PLH}$ ) and  $C_T$  Terminal External Capacitance

● Application Information

Explanation of Operation

For both the open drain type (Fig.15) and the CMOS output type (Fig.16), the detection and release voltages are used as threshold voltages. When the voltage applied to the VDD pins reaches the applicable threshold voltage, the Vout terminal voltage switches from either “High” to “Low” or from “Low” to “High”. BU42xx and BU43xx series have delay time function which set tPLH (Output “Low”→”High”) using an external capacitor (CT). Because the BU42xx series uses an open drain output type, it is necessary to connect a pull-up resistor to VDD or another power supply if needed [The output “High” voltage (VOUT) in this case becomes VDD or the voltage of the other power supply].



Fig.15 (BU42xx series Internal Block Diagram)



Fig.16 (BU43xx type Internal Block Diagram)

Setting of Detector Delay Time

The delay time of this detector IC can be set at the rise of VDD by the capacitor connected to CT terminal.

Delay time at the rise of VDD tPLH: Time until when Vout rises to 1/2 of VDD after VDD rises up and beyond the release voltage (VDET+ΔVDET)

$$T_{PLH} = -1 \times C_{CT} \times R_{CT} \times \ln \left( \frac{V_{DD} - V_{CTH}}{V_{DD}} \right)$$

CCT: CT pin Externally Attached Capacitance  
 RCT: CT pin Internal Impedance (P.3 RCT refer.)

VCTH: CT pin Threshold Voltage (P.3 VCTH refer.)  
 ln: Natural Logarithm

Reference Data of Falling Time (tPHL) Output

Examples of Falling Time (tPHL) Output

Part Number	tPHL [μs]
BU4245	275.7
BU4345	359.3

\* This data is for reference only.

The figures will vary with the application, so please confirm the actual operating conditions before use.

Timing Waveforms

Example: The following shows the relationship between the input voltage VDD, the CT Terminal Voltage VCT and the output voltage VOUT when the input power supply voltage VDD is made to sweep up and sweep down (The circuits are shown in Fig.15 and 16).

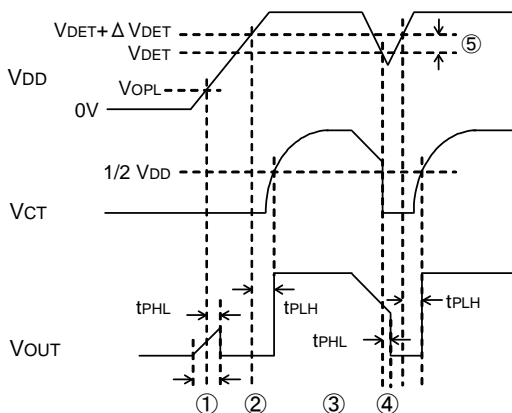


Fig.17 Timing Waveforms

- ① When the power supply is turned on, the output is unstable from after over the operating limit voltage (VOPL) until tPHL. Therefore, it is possible that the reset signal is not outputted when the rise time of VDD is faster than tPHL.
- ② When VDD is greater than VOPL but less than the reset release voltage (VDET+ΔVDET), the CT terminal (VCT) and output (VOUT) voltages will switch to L.
- ③ If VDD exceeds the reset release voltage (VDET+VDET), then VOUT switches from L to H (with a delay to the CT terminal).
- ④ If VDD drops below the detection voltage (VDET) when the power supply is powered down or when there is a power supply fluctuation, VOUT switches to L (with a delay of tPHL).
- ⑤ The potential difference between the detection voltage and the release voltage is known as the hysteresis width (VDET). The system is designed such that the output does not toggle with power supply fluctuations within this hysteresis width, preventing malfunctions due to noise.

●Circuit Applications

1) Examples of common power supply detection reset circuits



Fig.18 Open Drain Output type



Fig.19 CMOS Output type

Application examples of BU42xx series (Open Drain output type) and BU43xx series (CMOS output type) are shown below.

CASE1: Power supply of microcontroller ( $V_{DD2}$ ) differs from the power supply of the reset detection ( $V_{DD1}$ ). Use an open drain output Type (BU42xx series) device with a load resistance  $R_L$  as shown Fig.18.

CASE2: Power supply of microcontroller ( $V_{DD1}$ ) is the same as the power supply of the reset detection ( $V_{DD1}$ ). Use a CMOS output type (BU43xx series) device or an open drain output type (BU42xx series) device with a pull up resistor between the output and  $V_{DD1}$ .

When a capacitance  $C_L$  for noise filtering is connected to  $V_{OUT}$  pin (the reset signal input terminal of the microcontroller), please take into account the waveform of the rise and fall time of the output voltage ( $V_{OUT}$ ).

2) The following is an example of a circuit application in which an OR connection between two types of detection voltage resets the microcontroller.



Fig.20

To reset the microcontroller when many independent power supplies are used in the system, OR connect an open drain output type (BU42xx series) to the microcontroller's input with pull-up resistor to the supply voltage of the microcontroller ( $V_{DD3}$ ) as shown in Fig. 20. By pulling-up to  $V_{DD3}$ , output "High" voltage of micro-controller power supply is possible.

3) Examples of the power supply with resistor dividers

In applications wherein the power supply input terminal (VDD) of an IC has resistor dividers, it is possible that an in-rush current will momentarily flow into the circuit when the output logic switches, resulting in malfunctions (such as output oscillations).

(In-rush current is a current that momentarily flows from the power supply (VDD) to ground (GND) when the output level switches from "High" to "Low" or vice versa.)



Fig.21

A voltage drop [in-rush current (I1)] × [input resistor (R2)] is caused by the in-rush current, and causes the input voltage to drop when the output switches from "Low" to "High". When the input voltage decreases and falls below the detection voltage, the output voltage switches from "High" to "Low". At this time, the in-rush current stops flowing through output "Low", and the voltage drop is reduced. As a result, the output switches from "Low" to "High", which again causes the in-rush current to flow and the voltage to drop. This operation repeats and will result to oscillation.

Consider the use of BD52xx when the power supply input has resistor dividers.



Fig.22 Current Consumption vs. Power Supply Voltage

\* This data is for reference only.  
The figures will vary with the application, so please confirm the actual operating conditions before use.

## ●Operational Notes

- 1) Absolute maximum ratings  
Operating the IC over the absolute maximum ratings may damage the IC. The damage can either be a short circuit between pins or an open circuit between pins. Therefore, it is important to consider circuit protection measures, such as adding a fuse, in case the IC is operated over the absolute maximum ratings.
- 2) Ground Voltage  
The voltage of the ground pin must be the lowest voltage of all pins of the IC at all operating conditions. Ensure that no pins are at a voltage below the ground pin at any time, even during transient condition.
- 3) Recommended operating conditions  
These conditions represent a range within which the expected characteristics of the IC can be approximately obtained. The electrical characteristics are guaranteed under the conditions of each parameter.
- 4) Bypass Capacitor for Noise Rejection  
To help reject noise, put a 1 $\mu$ F capacitor between V<sub>DD</sub> pin and GND and 1000pF capacitor between V<sub>OUT</sub> pin and GND. Be careful when using extremely big capacitor as transient response will be affected.
- 5) Short between pins and mounting errors  
Be careful when mounting the IC on printed circuit boards. The IC may be damaged if it is mounted in a wrong orientation or if pins are shorted together. Short circuit may be caused by conductive particles caught between the pins.
- 6) Operation under strong electromagnetic field  
Operating the IC in the presence of a strong electromagnetic field may cause the IC to malfunction.
- 7) The V<sub>DD</sub> line impedance might cause oscillation because of the detection current.
- 8) A V<sub>DD</sub> to GND capacitor (as close connection as possible) should be used in high V<sub>DD</sub> line impedance condition.
- 9) Lower than the minimum input voltage puts the V<sub>OUT</sub> in high impedance state, and it must be V<sub>DD</sub> in pull up (V<sub>DD</sub>) condition.
- 10) External parameters  
The case of needless "Delay Time", recommended to insert more 470k $\Omega$  resistor between V<sub>DD</sub> and C<sub>T</sub>. The recommended value of R<sub>L</sub> Resistor is over 50k $\Omega$  to 1M $\Omega$  for V<sub>DET</sub>=1.5V to 4.8V, and over 100k $\Omega$  to 1M $\Omega$  for V<sub>DET</sub>=0.9V to 1.4V. The recommended value of C<sub>T</sub> Capacitor is over 100pF to 0.1 $\mu$ F. There are many factors (board layout, etc) that can affect characteristics. Please verify and confirm using practical applications.
- 11) Power on reset operation  
Please note that the power on reset output varies with the V<sub>DD</sub> rise time. Please verify the behavior in the actual operation.
- 12) Testing on application boards  
When testing the IC on an application board, connecting a capacitor directly to a low-impedance output pin may subject the IC to stress. Always discharge capacitors completely after each process or step. The IC's power supply should always be turned off completely before connecting or removing it from the test setup during the inspection process. To prevent damage from static discharge, ground the IC during assembly and use similar precautions during transport and storage.
- 13) Rush current  
When power is first supplied to the IC, rush current may flow instantaneously. It is possible that the charge current to the parasitic capacitance of internal photo diode or the internal logic may be unstable. Therefore, give special consideration to power coupling capacitance, power wiring, width of GND wiring, and routing of connections.
- 14) C<sub>T</sub> pin discharge  
Due to the capabilities of the C<sub>T</sub> pin discharge transistor, the C<sub>T</sub> pin may not completely discharge when a short input pulse is applied, and in this case the delay time may not be controlled. Please verify the actual operation.
- 15) This IC has extremely high impedance terminals. Small leak current due to the uncleanness of PCB surface might cause unexpected operations. Application values in these conditions should be selected carefully. If 10M $\Omega$  leakage is assumed between the C<sub>T</sub> terminal and the GND terminal, 1M $\Omega$  connection between the CT terminal and the V<sub>DD</sub> terminal would be recommended. Also, if the leakage is assumed between the Vout terminal and the GND terminal, the pull up resistor should be less than 1/10 of the assumed leak resistance. The value of R<sub>ct</sub> depends on the external resistor that is connected to C<sub>T</sub> terminal, so please consider the delay time that is decided by  $t \times R_{CT} \times C_{CT}$  changes.

# Notice

## Precaution on using ROHM Products

- Our Products are designed and manufactured for application in ordinary electronic equipments (such as AV equipment, OA equipment, telecommunication equipment, home electronic appliances, amusement equipment, etc.). If you intend to use our Products in devices requiring extremely high reliability (such as medical equipment <sup>(Note 1)</sup>, transport equipment, traffic equipment, aircraft/spacecraft, nuclear power controllers, fuel controllers, car equipment including car accessories, safety devices, etc.) and whose malfunction or failure may cause loss of human life, bodily injury or serious damage to property ("Specific Applications"), please consult with the ROHM sales representative in advance. Unless otherwise agreed in writing by ROHM in advance, ROHM shall not be in any way responsible or liable for any damages, expenses or losses incurred by you or third parties arising from the use of any ROHM's Products for Specific Applications.

(Note1) Medical Equipment Classification of the Specific Applications

JAPAN	USA	EU	CHINA
CLASS III	CLASS III	CLASS II b	CLASS III
CLASS IV		CLASS III	

- ROHM designs and manufactures its Products subject to strict quality control system. However, semiconductor products can fail or malfunction at a certain rate. Please be sure to implement, at your own responsibilities, adequate safety measures including but not limited to fail-safe design against the physical injury, damage to any property, which a failure or malfunction of our Products may cause. The following are examples of safety measures:
  - Installation of protection circuits or other protective devices to improve system safety
  - Installation of redundant circuits to reduce the impact of single or multiple circuit failure
- Our Products are designed and manufactured for use under standard conditions and not under any special or extraordinary environments or conditions, as exemplified below. Accordingly, ROHM shall not be in any way responsible or liable for any damages, expenses or losses arising from the use of any ROHM's Products under any special or extraordinary environments or conditions. If you intend to use our Products under any special or extraordinary environments or conditions (as exemplified below), your independent verification and confirmation of product performance, reliability, etc. prior to use, must be necessary:
  - Use of our Products in any types of liquid, including water, oils, chemicals, and organic solvents
  - Use of our Products outdoors or in places where the Products are exposed to direct sunlight or dust
  - Use of our Products in places where the Products are exposed to sea wind or corrosive gases, including Cl<sub>2</sub>, H<sub>2</sub>S, NH<sub>3</sub>, SO<sub>2</sub>, and NO<sub>2</sub>
  - Use of our Products in places where the Products are exposed to static electricity or electromagnetic waves
  - Use of our Products in proximity to heat-producing components, plastic cords, or other flammable items
  - Sealing or coating our Products with resin or other coating materials
  - Use of our Products without cleaning residue of flux (even if you use no-clean type fluxes, cleaning residue of flux is recommended); or Washing our Products by using water or water-soluble cleaning agents for cleaning residue after soldering
  - Use of the Products in places subject to dew condensation
- The Products are not subject to radiation-proof design.
- Please verify and confirm characteristics of the final or mounted products in using the Products.
- In particular, if a transient load (a large amount of load applied in a short period of time, such as pulse. is applied, confirmation of performance characteristics after on-board mounting is strongly recommended. Avoid applying power exceeding normal rated power; exceeding the power rating under steady-state loading condition may negatively affect product performance and reliability.
- De-rate Power Dissipation (Pd) depending on Ambient temperature (Ta). When used in sealed area, confirm the actual ambient temperature.
- Confirm that operation temperature is within the specified range described in the product specification.
- ROHM shall not be in any way responsible or liable for failure induced under deviant condition from what is defined in this document.

## Precaution for Mounting / Circuit board design

- When a highly active halogenous (chlorine, bromine, etc.) flux is used, the residue of flux may negatively affect product performance and reliability.
- In principle, the reflow soldering method must be used; if flow soldering method is preferred, please consult with the ROHM representative in advance.

For details, please refer to ROHM Mounting specification

**Precautions Regarding Application Examples and External Circuits**

1. If change is made to the constant of an external circuit, please allow a sufficient margin considering variations of the characteristics of the Products and external components, including transient characteristics, as well as static characteristics.
2. You agree that application notes, reference designs, and associated data and information contained in this document are presented only as guidance for Products use. Therefore, in case you use such information, you are solely responsible for it and you must exercise your own independent verification and judgment in the use of such information contained in this document. ROHM shall not be in any way responsible or liable for any damages, expenses or losses incurred by you or third parties arising from the use of such information.

**Precaution for Electrostatic**

This Product is electrostatic sensitive product, which may be damaged due to electrostatic discharge. Please take proper caution in your manufacturing process and storage so that voltage exceeding the Products maximum rating will not be applied to Products. Please take special care under dry condition (e.g. Grounding of human body / equipment / solder iron, isolation from charged objects, setting of ionizer, friction prevention and temperature / humidity control).

**Precaution for Storage / Transportation**

1. Product performance and soldered connections may deteriorate if the Products are stored in the places where:
  - [a] the Products are exposed to sea winds or corrosive gases, including Cl<sub>2</sub>, H<sub>2</sub>S, NH<sub>3</sub>, SO<sub>2</sub>, and NO<sub>2</sub>
  - [b] the temperature or humidity exceeds those recommended by ROHM
  - [c] the Products are exposed to direct sunshine or condensation
  - [d] the Products are exposed to high Electrostatic
2. Even under ROHM recommended storage condition, solderability of products out of recommended storage time period may be degraded. It is strongly recommended to confirm solderability before using Products of which storage time is exceeding the recommended storage time period.
3. Store / transport cartons in the correct direction, which is indicated on a carton with a symbol. Otherwise bent leads may occur due to excessive stress applied when dropping of a carton.
4. Use Products within the specified time after opening a humidity barrier bag. Baking is required before using Products of which storage time is exceeding the recommended storage time period.

**Precaution for Product Label**

QR code printed on ROHM Products label is for ROHM's internal use only.

**Precaution for Disposition**

When disposing Products please dispose them properly using an authorized industry waste company.

**Precaution for Foreign Exchange and Foreign Trade act**

Since our Products might fall under controlled goods prescribed by the applicable foreign exchange and foreign trade act, please consult with ROHM representative in case of export.

**Precaution Regarding Intellectual Property Rights**

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**Other Precaution**

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**General Precaution**

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